

Silicon Carbide (SiC) MOSFET - 20 mohm, 1200 V, M1, D2PAK-7L

NVBG020N120SC1

Features

- Typ. $R_{DS(on)} = 20 \text{ m}\Omega$
- Ultra Low Gate Charge (typ. $Q_{G(tot)} = 220 \text{ nC}$)
- Low Effective Output Capacitance (typ. C_{oss} = 258 pF)
- 100% Avalanche Tested
- AEC-Q101 Qualified and PPAP Capable
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb–Free 2LI (on second level interconnection)

Typical Applications

- Automotive On Board Charger
- Automotive DC-DC Converter for EV/HEV

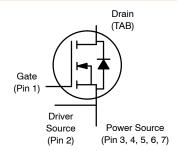
MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	1200	V
Gate-to-Source Voltage			V_{GS}	-15/+25	V
Recommended Operation Values of Gate-to-Source Voltage		V_{GSop}	-5/+20	>	
Continuous Drain Current (Note 2)	Steady State	T _C = 25°C	I _D	98	Α
Power Dissipation (Note 2)			P _D	468	W
Continuous Drain Current (Notes 1, 2)	Steady State	T _A = 25°C	I _D	8.6	Α
Power Dissipation (Notes 1, 2)			P _D	3.7	W
Pulsed Drain Current (Note 3)	T _A = 25°C		I _{DM}	392	Α
Single Pulse Surge Drain Current Capability	T_A = 25°C, t_p = 10 μ s, R_G = 4.7 Ω		I _{DSC}	807	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			IS	46	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 23 A, L = 1 mH) (Note 4)			E _{AS}	264	mJ
Maximum Lead Temperature for Soldering (1/8" from case for 5 s)			TL	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface mounted on a FR-4 board using 1 in 2 pad of 2 oz copper.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 3. Repetitive rating, limited by max junction temperature.
- 4. EAS of 264 mJ is based on starting $T_J = 25$ °C; L = 1 mH, $I_{AS} = 23$ A, $V_{DD} = 120$ V, $V_{GS} = 18$ V.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
1200 V	28 mΩ @ 20 V	98 A	



N-CHANNEL MOSFET



D2PAK-7L CASE 418BJ

MARKING DIAGRAM

AYWWZZ NVBG 020120SC1

A = Assembly Location

Y = Year WW = Work Week ZZ = Lot Traceability

NVBG020120SC1 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping [†]
NVBG020N120SC1	D2PAK-7L	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <u>BRD8011/D</u>.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case - Steady State (Note 2)		0.32	°C/W
Junction-to-Ambient - Steady State (Notes 1, 2)	$R_{ heta JA}$	41	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 1 mA	1200			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 1 mA, referenced to 25°C		0.5		V/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$, $T_{J} = 25^{\circ}C$			100	μΑ
		$V_{DS} = 1200 \text{ V}$ $T_{J} = 175^{\circ}\text{C}$			1	mA
Gate-to-Source Leakage Current	I _{GSS}	V _{GS} = +25/-15 V, V _{DS} = 0 V			±1	μΑ
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 20 \text{ mA}$	1.8	2.7	4.3	V
Recommended Gate Voltage	V_{GOP}		-5		+20	V
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = 20 \text{ V}, I_D = 60 \text{ A}, T_J = 25^{\circ}\text{C}$		20	28	mΩ
		V _{GS} = 20 V, I _D = 60 A, T _J = 175°C		35	50	
Forward Transconductance	9FS	V _{DS} = 20 V, I _D = 60 A		34		S
CHARGES, CAPACITANCES & GATE RES	SISTANCE					
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 800 V		2943		pF
Output Capacitance	Coss	1		258		
Reverse Transfer Capacitance	C _{RSS}	1		24		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -5/20 \text{ V}, V_{DS} = 600 \text{ V},$		220		nC
Threshold Gate Charge	Q _{G(TH)}	I _D = 80 A		33		
Gate-to-Source Charge	Q _{GS}	1		66		
Gate-to-Drain Charge	Q _{GD}	1		63		
Gate-Resistance	R_{G}	f = 1 MHz		1.6		Ω
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = -5/20 \text{ V},$		22	35	ns
Rise Time	t _r	V _{DS} = 800 V, I _D = 80 A,		20	32	
Turn-Off Delay Time	t _{d(OFF)}	R _G = 2 Ω inductive load		42	67	
Fall Time	t _f	Inductive load		9	18	
Turn-On Switching Loss	E _{ON}	1		461		μJ
Turn-Off Switching Loss	E _{OFF}	1		400		
Total Switching Loss	E _{tot}	1		861		
DRAIN-SOURCE DIODE CHARACTERIST	rics	•				
Continuous Drain-Source Diode Forward Current	I _{SD}	$V_{GS} = -5 \text{ V}, T_J = 25^{\circ}\text{C}$			46	Α
Pulsed Drain-Source Diode Forward Current (Note 3)	I _{SDM}				392	
Forward Diode Voltage	V _{SD}	$V_{GS} = -5 \text{ V}, I_{SD} = 30 \text{ A}, T_{J} = 25^{\circ}\text{C}$	Ī	3.7		V
Reverse Recovery Time	t _{RR}	$V_{GS} = -5/20 \text{ V}, I_{SD} = 80 \text{ A},$		31		ns
	-	dl _S /dt = 1000 A/μs	—	1		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

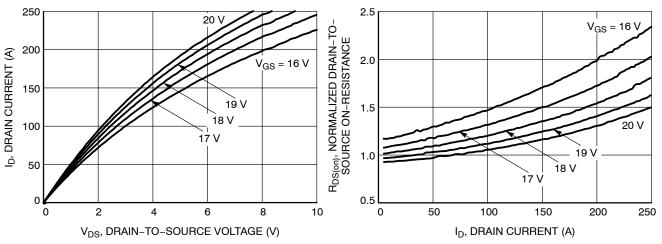


Figure 1. On-Region Characteristics

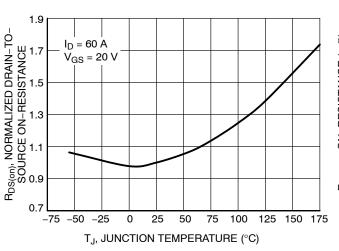


Figure 3. On–Resistance Variation with Temperature

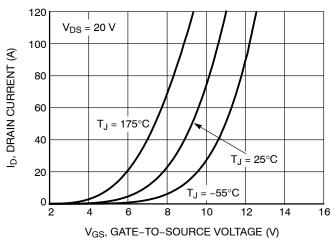


Figure 5. Transfer Characteristics

Figure 2. Normalized On–Resistance vs. Drain Current and Gate Voltage

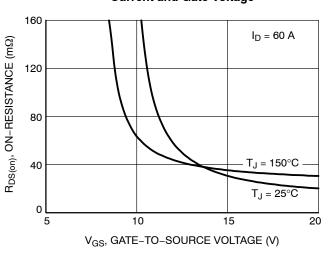


Figure 4. On-Resistance vs. Gate-to-Source Voltage

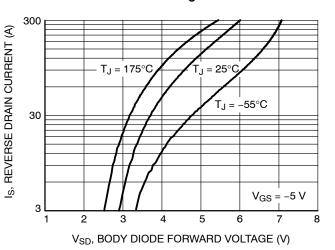


Figure 6. Diode Forward Voltage vs. Current

TYPICAL CHARACTERISTICS (continued)

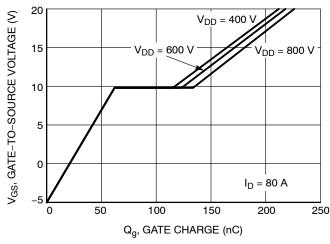


Figure 7. Gate-to-Source Voltage vs. Total Charge

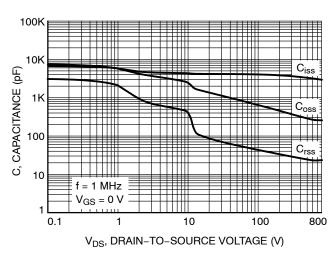


Figure 8. Capacitance vs. Drain-to-Source Voltage

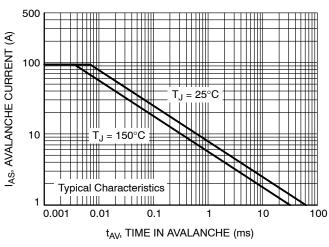


Figure 9. Unclamped Inductive Switching Capability

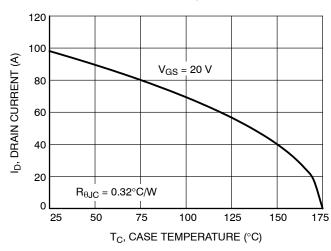


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

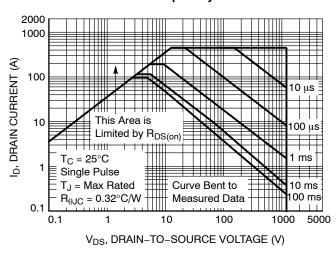


Figure 11. Maximum Rated Forward Biased Safe Operating Area

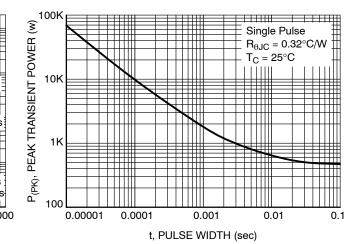


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued)

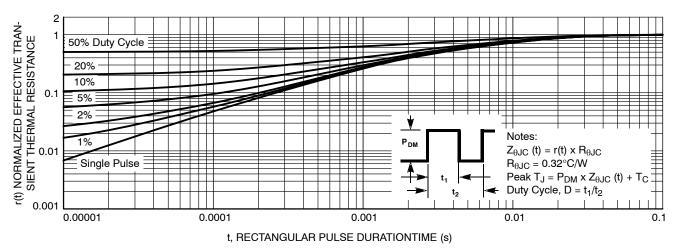
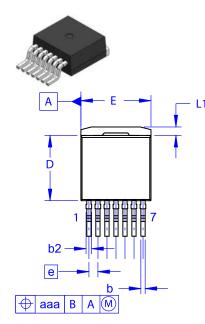
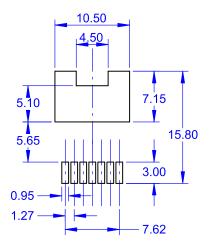


Figure 13. Junction-to-Case Transient Thermal Response Curve

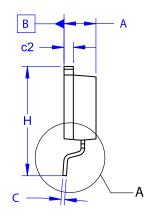




D²PAK7 (TO-263-7L HV) CASE 418BJ **ISSUE B**



LAND PATTERN RECOMMENDATION



DATE 16 AUG 2019

NOTES:

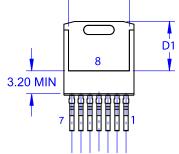
A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.

OUT OF JEDEC STANDARD VALUE.

D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.

E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

DIM	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	4.30	4.50	4.70		
A1	0.00	0.10	0.20		
b2	0.60	0.70	0.80		
b	0.51	0.60	0.70		
С	0.40	0.50	0.60		
c2	1.20	1.30	1.40		
D	9.00	9.20	9.40		
D1	6.15	6.80	7.15		
Е	9.70	9.90	10.20		
E1	7.15	7.65	8.15		
е	~	1.27	~		
Н	15.10	15.40	15.70		
L	2.44	2.64	2.84		
L1	1.00	1.20	1.40		
L3	~	0.25	~		
aaa	~	~	0.25		



E1

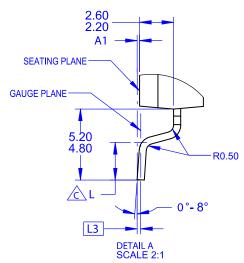




XXXX = Specific Device Code = Assembly Location

= Year WW = Work Week G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "=", may or may not be present. Some products may not follow the Generic Marking.



DOCUMENT NUMBER:	98AON84234G	Electronic versions are uncontrolled except when accessed directly from the Document Repositor Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	D ² PAK7 (TO-263-7L HV)		PAGE 1 OF 1	

onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. **onsemi** does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI., and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems. or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales